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October 25, 2002

Applicant(s): David Thomas BRITTON et al.

For

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Group: 3651

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Assistant Commissioner for Patents Washington, DC 20231

INFORMATION DISCLOSURE STATEMENT

Sir:

In compliance with the provisions of Rules 1.97(b)(1) and 1.98, enclosed herewith is Form PTO-1449 and the references cited thereon.

Also enclosed are copies of Patent Office Search Reports for the PCT and UK foreign patent application corresponding to the present application

Further consideration is respectfully solicited.

Respectfully submitted,

Mark L. Maki

MLM/cc

RECEIVED SAME GROUP 3600 H

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Encl: Form PTO-1449 and references cited thereon Copy of PCT Search Report dated May 24, 2002 Copy of UK Search Report dated June 21, 2001 Copy of five UK Search Reports dated January 8, 2002 Post Card

CERTIFICATE OF MAILING

I hereby certify that this correspondence is being deposited with the United States Postal Service as first class mail in an envelope addressed to: Assistant Commissioner for Patents, Washington, DC 20231, on October 28, 2002.

Respectfully submitted

Mark L. Maki

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